March 13, 2006

FN6053.3

Low-Voltage, Single and Dual Supply, 8 to 1 Multiplexer and Differential 4 to 1 Multiplexer

The Intersil ISL43681 and ISL43741 devices are precision, bidirectional, analog switches configured as an 8 channel and a differential 4 channel multiplexer/demultiplexer. They are designed to operate from a single +2V to +12V supply or from a \pm 2V to \pm 6V supplies. The devices have an inhibit and inhibit bar pin to simultaneously open all signal paths. The devices also have a latch bar pin to lock in the last switch address.

ON resistance of 39Ω with a $\pm 5V$ supply and 125Ω with a $\pm 3.3V$ supply. Each switch can handle rail to rail analog signals. The off-leakage current is only 0.1nA at $\pm 25^{\circ}$ C or 2.5nA at $\pm 85^{\circ}$ C

All digital inputs have 0.8V to 2.4V logic thresholds, ensuring TTL/CMOS logic compatibility when using a single 3.3V or +5V supply or dual ±5V supplies.

The ISL43681 is a single 8 to 1 multiplexer device and the ISL43741 is a diff 4 to 1 multiplexer device. Table 1 summarizes the performance of these parts.

TABLE 1. FEATURES AT A GLANCE

CONFIGURATION	SINGLE 8:1 MUX, DIFF 4:1 MUX
±5V R _{ON}	39Ω
±5V t _{ON} /t _{OFF}	32ns/18ns
12V R _{ON}	32Ω
12V t _{ON} /t _{OFF}	23ns/15ns
5V R _{ON}	65Ω
5V t _{ON} /t _{OFF}	38ns/19ns
3.3V R _{ON}	125Ω
3.3V t _{ON} /t _{OFF}	70ns/32ns
Package	20 Ld 4x4 QFN

Related Literature

- Technical Brief TB363 "Guidelines for Handling and Processing Moisture Sensitive Surface Mount Devices (SMDs)"
- Application Note AN557 "Recommended Test Procedures for Analog Switches"
- Application Note AN520 "CMOS Analog Multiplexers and Switches; Specifications and Application Considerations."
- Application Note AN1034 "Analog Switch and Multiplexer Applications"

Features

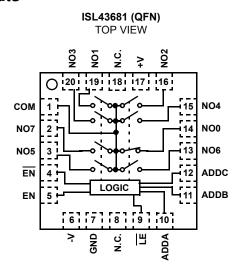
•	Fully Specified at 3.3V, 5V, $\pm 5\text{V},$ and 12V Supplies for 10% Tolerances
•	ON Resistance (R _{ON}) Max, V _S = ± 4.5 V 50 Ω
•	ON Resistance (R _{ON}) Max, V_S = +3 V 155 Ω
•	R _{ON} Matching Between Channels, V _S = $\pm 5V<2\Omega$
•	Low Charge Injection, V_S = $\pm 5V$ 1pC (Max)
•	Single Supply Operation +2V to +12V
•	Dual Supply Operation $\pm 2V$ to $\pm 6V$
•	Fast Switching Action (V _S = +5V)
	- t _{ON}
	Guaranteed Max Off-leakage2.5nA
	•
•	Guaranteed Break-Before-Make

- · TTL, CMOS Compatible
- · Pb-Free Plus Anneal Available (RoHS Compliant)

Applications

- · Battery Powered, Handheld, and Portable Equipment
- · Communications Systems
 - Radios
 - Telecom Infrastructure
 - ADSL, VDSL Modems
- · Test Equipment
 - Medical Ultrasound
 - Magnetic Resonance Image
 - CT and PET Scanners (MRI)
 - ATE
- Electrocardiograph
- · Audio and Video Signal Routing
- · Various Circuits
 - +3V/+5V DACs and ADCs
 - Sample and Hold Circuits
 - Operational Amplifier Gain Switching Networks
 - High Frequency Analog Switching
 - High Speed Multiplexing
 - Integrator Reset Circuits

Pinouts



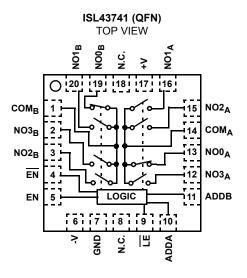
Truth Tables

	ISL43681									
LE	EN	EN	ADDC	ADDB	ADDA	SWITCH ON				
0	1	0	Х	Х	Х	Last Switch Selected				
Х	0	Х	Х	Х	Х	NONE				
Х	Х	1	Х	Х	Х	NONE				
1	1	0	0	0	0	NO0				
1	1	0	0	0	1	NO1				
1	1	0	0	1	0	NO2				
1	1	0	0	1	1	NO3				
1	1	0	1	0	0	NO4				
1	1	0	1	0	1	NO5				
1	1	0	1	1	0	NO6				
1	1	0	1	1	1	NO7				

NOTE: Logic "0" \leq 0.8V. Logic "1" \geq 2.4V, with V+ between 2.7V and 10V. X = Don't Care.

	ISL43741									
LE	EN	EN	ADDB	DB ADDA SWITCH ON						
0	1	0	Х	Х	Last Switch Selected					
Х	0	Х	Х	Х	NONE					
Х	Х	1	Х	Х	NONE					
1	1	0	0	0	NO0 _A , NO0 _B					
1	1	0	0	1	NO1 _A , NO1 _B					
1	1	0	1	0	NO2 _A , NO2 _B					
1	1	0	1	1	NO3 _A , NO3 _B					

NOTE: Logic "0" \leq 0.8V. Logic "1" \geq 2.4V, with V+ between 2.7V and 10V. X = Don't Care.



Ordering Information

PART NO.	PART MARKING	TEMP. RANGE (°C)	PACKAGE	PKG. DWG. #
ISL43681IR	43681IR	-40 to 85	20 Ld QFN	L20.4x4
ISL43681IRZ (Note)	43681IRZ	-40 to 85	20 Ld QFN (Pb-free)	L20.4x4
ISL43741IR	43741IR	-40 to 85	20 Ld QFN	L20.4x4
ISL43741IRZ (Note)	43741IRZ	-40 to 85	20 Ld QFN (Pb-free)	L20.4x4

*Add "-T" suffix for tape and reel.

NOTE: Intersil Pb-free plus anneal products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

Pin Descriptions

PIN	FUNCTION
V+	Positive Power Supply Input
V-	Negative Power Supply Input. Connect to GND for Single Supply Configurations.
GND	Ground Connection
ĒN	Digital Control Input. Connect to GND for Normal Operation. Connect to V+ to turn all switches off.
EN	Digital Control Input. Connect to V+ for Normal Operation. Connect to GND to turn all switches off.
ĪĒ	Digital Control Input. Connect to +V for Normal Operation. Connect to GND to latch the last switch state.
COM	Analog Switch Common Pin
NO	Analog Switch Normally Open Pin
ADD	Address Input Pin
N.C.	No Internal Connection

Absolute Maximum Ratings

V+ to V0.3 to15V
V+ to GND0.3 to15V
V- to GND
Input Voltages
$\overline{\text{LE}}$, $\overline{\text{EN}}$, EN, NO, NC, ADD (Note 1)0.3 to ((V+) + 0.3V)
Output Voltages
COM (Note 1)0.3 to ((V+) + 0.3V)
Continuous Current (Any Terminal) ±30mA
Peak Current NO, NC, or COM
(Pulsed 1ms, 10% Duty Cycle, Max) ±100mA
ESD Rating
HBM (Per Mil-STD-883, Method 3015.7) >2.5kV

Thermal Information

Thermal Resistance (Typical, Note 2)	θ _{JA} (°C/W)
20 Ld 4x4 QFN Package	. 45
Maximum Junction Temperature (Plastic Package)	150°C
Maximum Storage Temperature Range	-65°C to 150°C
Maximum Lead Temperature (Soldering 10s)	300°C
(Lead Tips Only)	

Operating Conditions

Temperature Range ISL43681IR and ISI43741IR-40°C to 85°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTES:

- 1. Signals on NC, NO, COM, ADD, EN, $\overline{\text{EN}}$, or $\overline{\text{LE}}$ exceeding V+ or V- are clamped by internal diodes. Limit forward diode current to maximum current ratings.
- 2. θ_{JA} is measured with the component mounted on a high effective thermal conductivity test board with direct die attach. See Tech Brief TB379 for details.

Electrical Specifications ±5V SupplyTest Conditions: V_{SUPPLY} = ±4.5V to ±5.5V, GND = 0V, V_{INH} = 2.4V, V_{INL} = 0.8V (Note 3), Unless Otherwise Specified

PARAMETER	TEST CONDITIONS	TEMP (°C)	(NOTE 4) MIN	TYP	(NOTE 4) MAX	UNITS
ANALOG SWITCH CHARACTERIS	STICS					
Analog Signal Range, V _{ANALOG}		Full	V-	-	V+	V
ON Resistance, R _{ON}	V_S = ± 4.5 V, I_{COM} = 2mA, V_{NO} or V_{NC} = 3V (See Figure 6)	25	-	44	60	Ω
		Full	-	-	80	Ω
R _{ON} Matching Between Channels,	$V_S = \pm 4.5 \text{V}$, $I_{COM} = 2 \text{mA}$, V_{NO} or $V_{NC} = 3 \text{V}$ (Note 5)	25	-	1.3	4	Ω
ΔR_{ON}		Full	-	-	6	Ω
R _{ON} Flatness, R _{FLAT(ON)}	V_S = ±4.5V, I_{COM} = 2mA, V_{NO} or V_{NC} = ±3V, 0V (Note 6)	25	-	7.5	9	Ω
		Full	-	-	12	Ω
NO or NC OFF Leakage Current,	V_S = ±5.5V, V_{COM} = ±4.5V, V_{NO} or V_{NC} = +4.5V (Note 7)	25	-0.1	0.002	0.1	nA
I _{NO(OFF)} or I _{NC(OFF)}		Full	-2.5	-	2.5	nA
COM OFF Leakage Current,	$V_S = \pm 5.5$ V, $V_{COM} = \pm 4.5$ V, V_{NO} or $V_{NC} = +4.5$ V (Note 7)	25	-0.1	0.002	0.1	nA
ICOM(OFF)		Full	-2.5	-	2.5	nA
COM ON Leakage Current,	$V_S = \pm 5.5V$, $V_{COM} = V_{NO}$ or $V_{NC} = \pm 4.5V$ (Note 7)	25	-0.1	0.002	0.1	nA
ICOM(ON)		Full	-2.5	-	2.5	nA
DIGITAL INPUT CHARACTERISTIC	cs		1	I		l.
Input Voltage High, V _{INH} , V _{ADDH}		Full	2.4	-	-	V
Input Voltage Low, V _{INL} , V _{ADDL}		Full	-	-	0.8	V
Input Current, I _{ADDH} , I _{ADDL} , I _{ENH} , I _{ENL}	$V_S = \pm 5.5V$, V_{INH} , $V_{ADD} = 0V$ or V+	Full	-0.5	-	0.5	μA
Input Current, I _{ENH} , I _{LEH}	$V_S = \pm 5.5 \text{V}$, V_{INH} , $V_{ADD} = 0 \text{V}$ or V+	Full	-1.5	-	1.5	μA
Input Current, I _{ENL} , I _{LEL}	$V_S = \pm 5.5V$, V_{INH} , $V_{ADD} = 0V$ or $V+$	Full	-4	-	4	μA

Electrical Specifications ±5V SupplyTest Conditions: V_{SUPPLY} = ±4.5V to ±5.5V, GND = 0V, V_{INH} = 2.4V, V_{INL} = 0.8V (Note 3), Unless Otherwise Specified (**Continued**)

PARAMETER	TEST CONDITIONS		TEMP (°C)	(NOTE 4) MIN	TYP	(NOTE 4) MAX	UNITS
DYNAMIC CHARACTERISTICS						<u> </u>	
Enable Turn-ON Time, t _{ON}	V_S = ±4.5V, V_{NO} or V_{NC} = ±3V, R_L = 300 Ω , C_L = 35pF,		25	-	35	50	ns
	V _{IN} = 0 to 3 (See Figure 1)		Full	-	-	60	ns
Enable Turn-OFF Time, t _{OFF}	$V_S = \pm 4.5 \text{V}$, V_{NO} or $V_{NC} = \pm 3 \text{V}$, $R_L = 300 \text{G}$	2, C _L = 35pF,	25	-	22	35	ns
	V _{IN} = 0 to 3 (See Figure 1)	IN = 0 to 3 (See Figure 1)		-	-	40	ns
Address Transition Time, t _{TRANS}	$V_{\rm S}$ = ±4.5V, $V_{\rm NO}$ or $V_{\rm NC}$ = ±3V, $R_{\rm L}$ = 300 Ω , $C_{\rm L}$ = 35pF, $V_{\rm IN}$ = 0 to 3 (See Figure 1)		25	-	43	60	ns
			Full	-	-	70	ns
Break-Before-Make Time, t _{BBM}	$V_S = \pm 5.5$ V, V_{NO} or $V_{NC} = 3$ V, $R_L = 300$ C $V_{IN} = 0$ to 3V (See Figure 3)	$V_S = \pm 5.5 \text{V}$, V_{NO} or $V_{NC} = 3 \text{V}$, $R_L = 300 \Omega$, $C_L = 35 \text{pF}$, $V_{IN} = 0$ to 3V (See Figure 3)		2	7	-	ns
Latch Setup Time, t _S	(See Figure 4)		25	25	-	-	ns
		Full	35	-	-	ns	
Latch Hold Time, t _H	(See Figure 4)		25	0	-	-	ns
			Full	0	-	-	ns
Latch Pulse Width, t _{WPW}	(See Figure 4)		25	15	-	-	ns
			Full	25	-		ns
Charge Injection, Q	C_L = 1.0nF, V_G = 0V, R_G = 0 Ω (See Figu	re 2)	25	-	0.3	1	pC
NO/NC OFF Capacitance, COFF	$f = 1MHz$, V_{NO} or $V_{NC} = V_{COM} = 0V$ (Se	e Figure 8)	25	-	3	-	pF
COM OFF Capacitance, C _{OFF}	f = 1MHz, V _{NO} or V _{NC} = V _{COM} = 0V	ISL43681	25	-	21	-	pF
	(See Figure 8)	ISL43741	25	-	12	-	pF
COM ON Capacitance, C _{COM(ON)}	f = 1MHz, V _{NO} or V _{NC} = V _{COM} = 0V	ISL43681	25	-	26	-	pF
	(See Figure 8)	ISL43741	25	-	18	-	pF
OFF Isolation	$R_L = 50\Omega$, $C_L = 15pF$, $f = 100kHz$,		25	-	92	-	dB
Crosstalk, (Note 8) (ISL43741 only)	V _{NOx} = 1V _{RMS} (See Figures 5, 7 and 20)	25	-	≤110	-	dB
All Hostile Crosstalk, (Note 8) (ISL43741 only)			25	-	-105	-	dB
POWER SUPPLY CHARACTERIST	rics			1			1
Power Supply Range			Full	±2	-	±6	V
Positive Supply Current, I+	$V_S = \pm 5.5V$, V_{INH} , $V_{ADD} = 0V$ or V+, Swi	ch On or Off	Full	-7	-	7	μΑ
Negative Supply Current, I-			Full	-1	-	1	μA

NOTES:

- 3. V_{IN} = Input logic voltage to configure the device in a given state.
- 4. The algebraic convention, whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
- 5. $\Delta R_{ON} = R_{ON} (MAX) R_{ON} (MIN)$.
- 6. Flatness is defined as the difference between maximum and minimum value of on-resistance over the specified analog signal range.
- 7. Leakage parameter is 100% tested at high temp, and guaranteed by correlation at 25°C.
- 8. Between any two switches.

Electrical Specifications +12V Supply

Test Conditions: V+ = +10.8V to +13.2V, GND = 0V, V_{INH} = 4V, V_{INL} = 0.8V (Note 3), Unless Otherwise Specified

PARAMETER	TEST CONDITIONS	TEMP (°C)	(NOTE 4) MIN	TYP	(NOTE4) MAX	UNITS
ANALOG SWITCH CHARACTERIS	STICS	<u>I</u>			- 1	1
Analog Signal Range, V _{ANALOG}		Full	0	-	V+	V
ON Resistance, R _{ON}	V+ = 10.8V, I _{COM} = 1.0mA, V _{NO} or V _{NC} = 9V	25	-	37	45	Ω
	(See Figure 6)	Full	-	-	55	Ω
R _{ON} Matching Between Channels,	V+ = 10.8V, I _{COM} = 1.0mA, V _{NO} or V _{NC} = 9V (Note 5)	25	-	1.2	2	Ω
AR _{ON}		Full	-	-	2	Ω
R _{ON} Flatness, R _{FLAT(ON)}	V+ = 10.8V, I _{COM} = 1.0mA, V _{NO} or V _{NC} = 3V, 6V, 9V	25	-	5	7	Ω
	(Note 6)	Full	-	-	7	Ω
NO or NC OFF Leakage Current,	V+ = 13.2V, V _{COM} = 1V, 12V, V _{NO} or V _{NC} = 12V, 1V	25	-0.1	0.002	0.1	nA
I _{NO(OFF)} or I _{NC(OFF)}	(Note 7)	Full	-2.5	-	2.5	nA
COM OFF Leakage Current,	V+ = 13.2V, V _{COM} = 12V, 1V, V _{NO} or V _{NC} = 1V, 12V	25	-0.1	0.002	0.1	nA
I _{COM(OFF)}	(Note 7)	Full	-2.5	-	2.5	nA
COM ON Leakage Current,	V+ = 13.2V, V _{COM} = 1V, 12V, V _{NO} or V _{NC} = 1V, 12V,	25	-0.1	0.002	0.1	nA
I _{COM(ON)}	or floating (Note 7)		-2.5	-	2.5	nA
DIGITAL INPUT CHARACTERISTI	cs					
Input Voltage High, V _{INH} , V _{ADDH}		Full	3.7	3.3	-	V
Input Voltage Low, V _{INL} , V _{ADDL}		Full	-	2.7	0.8	V
Input Current, I _{ADDH} , I _{ADDL} , I <u>EN</u> H, I <u>EN</u> L	V+ = 13.2V, V _{INH} , V _{ADD} = 0V or V+	Full	-0.5	-	0.5	μA
Input Current, I _{ENH} , I _{LEH}	V+ = 13.2V, V _{INH} , V _{ADD} = 0V or V+	Full	-1.5	-	1.5	μΑ
Input Current, I _{ENL} , I _{LEL}	V+ = 13.2V, V _{INH} , V _{ADD} = 0V or V+	Full	-4	-	4	μA
DYNAMIC CHARACTERISTICS		1	1		1	Ш
Enable Turn-ON Time, t _{ON}	$V+ = 10.8V$, V_{NO} or $V_{NC} = 10V$, $R_L = 300\Omega$, $C_L = 35pF$,	25	-	24	40	ns
	V _{IN} = 0 to 4 (See Figure 1)	Full	-	-	45	ns
Enable Turn-OFF Time, t _{OFF}	$V+ = 10.8V$, V_{NO} or $V_{NC} = 10V$, $R_L = 300\Omega$, $C_L = 35pF$,	25	-	15	30	ns
	V _{IN} = 0 to 4 (See Figure 1)	Full	-	-	35	ns
Address Transition Time, t _{TRANS}	$V+ = 10.8V$, V_{NO} or $V_{NC} = 10V$, $R_L = 300\Omega$, $C_L = 35pF$,	25	-	27	50	ns
	V _{IN} = 0 to 4 (See Figure 1)	Full	-	-	55	ns
Break-Before-Make Time Delay, t _D	V + = 13.2V, R_L = 300 Ω , C_L = 35pF, V_{NO} or V_{NC} = 10V, V_{IN} = 0 to 4 (See Figure 3)	Full	2	5	-	ns
Latch Setup Time, t _S	(See Figure 4)	25	25	-	-	ns
		Full	35	-	-	ns
Latch Hold Time, t _H	(See Figure 4)	25	0	-	-	ns
		Full	0	-	-	ns
Latch Pulse Width, t _{WPW}	(See Figure 4)	25	15	-	-	ns
		Full	25	-	-	ns
Charge Injection, Q	$C_L = 1.0$ nF, $V_G = 0$ V, $R_G = 0$ Ω (See Figure 2)	25	_	2.7	5	рС

Electrical Specifications +12V Supply

Test Conditions: V+ = +10.8V to +13.2V, GND = 0V, V_{INH} = 4V, V_{INL} = 0.8V (Note 3), Unless Otherwise Specified (Continued)

PARAMETER	TEST CONDITIONS		TEMP (°C)	(NOTE 4) MIN	TYP	(NOTE4) MAX	UNITS
OFF Isolation	$R_L = 50\Omega$, $C_L = 15pF$, $f = 100kHz$		25	-	92	-	dB
Crosstalk, (Note 8), (ISL43741 only)	(See Figure 5,7 and 20)		25	-	≤110	-	dB
All Hostile Crosstalk, (Note 8) (ISL43741 only)			25	-	-105	-	dB
NO or NC OFF Capacitance, COFF	f = 1MHz, V _{NO} or V _{NC} = V _{COM} = 0V (See Figure 8)		25	-	3	-	pF
COM OFF Capacitance,	f = 1MHz, V_{NO} or $V_{NC} = V_{COM} = 0V$ (See Figure 8)	ISL43681	25	-	21	-	pF
C _{COM(OFF)}		ISL43741	25	-	12	-	pF
COM ON Capacitance, C _{COM(ON)}	f = 1MHz, V _{NO} or V _{NC} = V _{COM} = 0V	ISL43681	25	-	26	-	pF
	(See Figure 8)	ISL43741	25	-	18	-	pF
POWER SUPPLY CHARACTERIST	ics					1	
Power Supply Range			Full	2	-	12	V
Positive Supply Current, I+	V+ = 13.2V, V _{INH} , V _{ADD} = 0V or V+, all channels on or		Full	-7	-	7	μA
Positive Supply Current, I-	off		Full	-1	-	1	μA

Electrical Specifications 5V Supply

Test Conditions: V+ = +4.5V to +5.5V, V- = GND = 0V, V_{INH} = 2.4V, V_{INL} = 0.8V (Note 3), Unless Otherwise Specified

PARAMETER	TEST CONDITIONS	TEMP (°C)	MIN (NOTE 4)	TYP	MAX (NOTE 4)	UNITS
ANALOG SWITCH CHARACTERIS	BTICS	U.	1		"	L.
Analog Signal Range, V _{ANALOG}		Full	0	-	V+	V
ON Resistance, R _{ON}	V+ = 4.5V, I_{COM} = 1.0mA, V_{NO} or V_{NC} = 3.5V (See Figure 6)	25	-	81	100	Ω
		Full	-	-	120	Ω
R _{ON} Matching Between Channels,	V+ = 4.5V, I _{COM} = 1.0mA, V _{NO} or V _{NC} = 3V (Note 5)	25	-	2.2	4	Ω
ΔR_{ON}		Full	-	-	6	Ω
R _{ON} Flatness, R _{FLAT(ON)}	V+ = 4.5V, I _{COM} = 1.0mA, V _{NO} or V _{NC} = 1V, 2V, 3V (Note 6)	Full	-	11.5	-	Ω
NO or NC OFF Leakage Current, INO(OFF) or INC(OFF)	V+ = 5.5V, V _{COM} = 1V, 4.5V, V _{NO} or V _{NC} = 4.5V, 1V (Note 7)	25	-0.1	0.002	0.1	nA
		Full	-2.5	-	2.5	nA
COM OFF Leakage Current, ICOM(OFF)	V+ = 5.5V, V _{COM} = 1V, 4.5V, V _{NO} or V _{NC} = 4.5V, 1V (Note 7)	25	-0.1	0.002	0.1	nA
		Full	-2.5	-	2.5	nA
COM ON Leakage Current, ICOM(ON)	$V+ = 5.5V$, $V_{COM} = V_{NO}$ or $V_{NC} = 4.5V$ (Note 7)	25	-0.1	0.002	0.1	nA
		Full	-2.5	-	2.5	nA
DIGITAL INPUT CHARACTERISTIC	cs					
Input Voltage High, V _{INH} , V _{ADDH}		Full	2.4	-	-	V
Input Voltage Low, V _{INL} , V _{ADDL}		Full	-	-	0.8	V
Input Current, I _{ADDH} , I _{ADDL} , I _{ENH} , I _{ENL}	V+ = 5.5V, V _{INH} , V _{ADD} = 0V or V+	Full	-0.5	-	0.5	μA
Input Current, I _{ENH} , I _{LEH}	V+ = 5.5V, V _{INH} , V _{ADD} = 0V or V+	Full	-1.5	-	1.5	μΑ
Input Current, I _{ENL} , I _{LEL}	V+ = 5.5V, V _{INH} , V _{ADD} = 0V or V+	Full	-4	-	4	μA

Electrical Specifications 5V Supply

Test Conditions: V+ = +4.5V to +5.5V, V- = GND = 0V, V_{INH} = 2.4V, V_{INL} = 0.8V (Note 3), Unless Otherwise Specified **(Continued)**

PARAMETER	TEST CONDITIONS	TEMP (°C)	MIN (NOTE 4)	TYP	MAX (NOTE 4)	UNITS		
DYNAMIC CHARACTERISTICS								
Enable Turn-ON Time, t _{ON}	V+ = 4.5V, V _{NO} or V _{NC} = 3V, R _L = 300 Ω , C _L = 35pF, V _{IN} = 0 to 3V (See Figure 1)	25	-	43	60	ns		
		Full	-	-	70	ns		
Enable Turn-OFF Time, t _{OFF}	V+ = 4.5V, V_{NO} or V_{NC} = 3V, R_L = 300 Ω , C_L = 35pF, V_{IN} = 0 to 3V (See Figure 1)	25	-	20	35	ns		
		Full	-	-	40	ns		
Address Transition Time, t _{TRANS}	$V+ = 4.5V$, V_{NO} or $V_{NC} = 3V$, $R_L = 300\Omega$, $C_L = 35pF$,	25	-	51	70	ns		
	V _{IN} = 0 to 3V (See Figure 1)	Full	-	-	85	ns		
Break-Before-Make Time, t _{BBM}	V+ = 5.5V, V_{NO} or V_{NC} = 3V, R_L = 300 Ω , C_L = 35pF, V_{IN} = 0 to 3V (See Figure 3)	Full	2	9	-	ns		
Latch Setup Time, t _S	(See Figure 4)	25	25	-	-	ns		
		Full	35	-	-	ns		
Latch Hold Time, t _H	(See Figure 4)	25	0	-	-	ns		
		Full	0	-	-	ns		
Latch Pulse Width, t _{WPW}	(See Figure 4)	25	15	-	-	ns		
		Full	25	-	-	ns		
Charge Injection, Q	$C_L = 1.0$ nF, $V_G = 0$ V, $R_G = 0\Omega$ (See Figure 2)	25	-	0.6	1.5	pC		
OFF Isolation	$R_L = 50\Omega$, $C_L = 15pF$, $f = 100kHz$,	25	-	92	-	dB		
Crosstalk, (Note 8), (ISL43741 only)	V _{NOx} = 1V _{RMS} (See Figures 5, 7 and 20)	25	-	≤110	-	dB		
All Hostile Crosstalk, (Note 8), (ISL43741 only)		25	1	-105	1.5	dB		
POWER SUPPLY CHARACTERISTICS								
Power Supply Range		Full	2	-	12	V		
Positive Supply Current, I+	V+ = 5.5V, V- = 0V, V _{INH} , V _{ADD} = 0V or V+,	Full	-7	-	7	μΑ		
Positive Supply Current, I-	Switch On or Off	Full	-1	-	1	μΑ		

Electrical Specifications 3.3V SupplyTest Conditions: V+ = +3.0V to +3.6V, V- = GND = 0V, V_{INH} = 2.4V, V_{INL} = 0.8V (Note 3), Unless Otherwise Specified

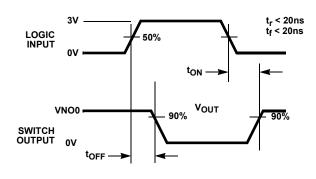
PARAMETER	TEST CONDITIONS	TEMP (°C)	MIN (NOTE 4)	TYP	MAX (NOTE 4)	UNITS		
ANALOG SWITCH CHARACTERISTICS								
Analog Signal Range, V _{ANALOG}		Full	0	-	V+	V		
ON Resistance, R _{ON}	V+ = 3.0V, I_{COM} = 1.0mA, V_{NO} or V_{NC} = 1.5V (See Figure 6)	25	-	135	180	Ω		
		Full	-	-	200	Ω		
$R_{\mbox{ON}}$ Matching Between Channels, $\Delta R_{\mbox{ON}}$	$V+ = 3.0V$, $I_{COM} = 1.0$ mA, V_{NO} or $V_{NC} = 1.5V$ (Note 5)	25	-	3.4	8	Ω		
		Full	-	-	10	Ω		
R _{ON} Flatness, R _{FLAT(ON)}	$V+ = 3.0V$, $I_{COM} = 1.0$ mA, V_{NO} or $V_{NC} = 0.5V$, $1V$, $2V$ (Note 6)	Full	-	34	-	Ω		
NO or NC OFF Leakage Current,	V+ = 3.6V, V _{COM} = 0V, 4.5V, V _{NO} or V _{NC} = 3V, 1V (Note 7)	25	-0.1	0.002	0.1	nA		
INO(OFF) or INC(OFF)		Full	-2.5	-	2.5	nA		
COM OFF Leakage Current, ICOM(OFF)	V+ = 3.6V, V _{COM} = 0V, 4.5V, V _{NO} or V _{NC} = 3V, 1V (Note 7)	25	-0.1	0.002	0.1	nA		
		Full	-2.5	-	2.5	nA		

ISL43681, ISL43741

Electrical Specifications 3.3V SupplyTest Conditions: V+ = +3.0V to +3.6V, V- = GND = 0V, $V_{INH} = 2.4V$, $V_{INL} = 0.8V$ (Note 3), Unless Otherwise Specified (**Continued**)

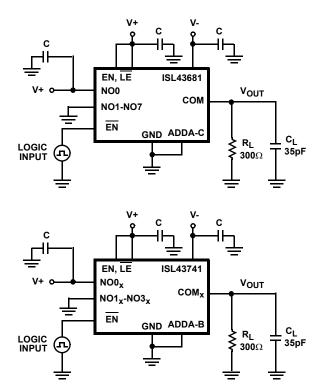
PARAMETER	TEST CONDITIONS	TEMP (°C)	MIN (NOTE 4)	TYP	MAX (NOTE 4)	UNITS
COM ON Leakage Current,	V+ = 3.6V, V _{COM} = V _{NO} or V _{NC} = 3V (Note 7)	25	-0.1	0.002	0.1	nA
ICOM(ON)		Full	-2.5	-	2.5	nA
DIGITAL INPUT CHARACTERISTIC	cs					
Input Voltage High, V _{INH} , V _{ADDH}		Full	2.4	-	-	V
Input Voltage Low, V _{INL} , V _{ADDL}		Full	-	-	0.8	V
Input Current, I_{ADDH} , I_{ADDL} , $I_{\overline{EN}H}$, $I_{\overline{EN}L}$	V+ = 3.6V, V _{INH} , V _{ADD} = 0V or V+	Full	-0.5	-	0.5	μA
Input Current, I _{ENH} , I _{LEH}	V+ = 3.6V, V _{INH} , V _{ADD} = 0V or V+	Full	-1.5	-	1.5	μA
Input Current, I _{ENL} , I _{LEL}	V+ = 3.6V, V _{INH} , V _{ADD} = 0V or V+	Full	-4	-	4	μA
DYNAMIC CHARACTERISTICS			1			
Enable Turn-ON Time, t _{ON}	V + = 3.0V, V_{NO} or V_{NC} = 1.5V, R_L = 300 Ω , C_L = 35pF,	25	-	82	100	ns
	V _{IN} = 0 to 3V (See Figure 1)	Full	-	-	120	ns
Enable Turn-OFF Time, t _{OFF}	V+ = 3.0V, V_{NO} or V_{NC} = 1.5V, R_L = 300 Ω , C_L = 35pF, V_{IN} = 0 to 3V (See Figure 1)	25	-	37	50	ns
		Full	-	-	60	ns
Address Transition Time, t _{TRANS}	V+ = 3.0V, V_{NO} or V_{NC} = 1.5V, R_L = 300 Ω , C_L = 35pF, V_{IN} = 0 to 3V (See Figure 1)	25	-	96	120	ns
		Full	-	-	145	ns
Break-Before-Make Time, t _{BBM}	V+ = 3.6V, V_{NO} or V_{NC} = 1.5V, R_L = 300 Ω , C_L = 35pF, V_{IN} = 0 to 3V (See Figure 3)		3	13	-	ns
Latch Setup Time, t _S	(See Figure 4)	25	50	-	-	ns
		Full	60	-	-	ns
Latch Hold Time, t _H	(See Figure 4)	25	0	-	-	ns
			0	-	-	ns
Latch Pulse Width, t _{WPW}	(See Figure 4)	25	30	-	-	ns
			40	-	-	ns
Charge Injection, Q	C_L = 1.0nF, V_G = 0V, R_G = 0 Ω (See Figure 2)	25	-	0.3	1	рС
OFF Isolation	$R_L = 50\Omega$, $C_L = 15pF$, $f = 100kHz$,	25	-	92	-	dB
Crosstalk, (Note 8), (ISL43741 only)	V_{NO} or V_{NC} = 1 V_{RMS} (See Figures 5, 7 and 20)		-	≤110	-	dB
All Hostile Crosstalk, (Note 8), (ISL43741 only)			-	-105	-	dB
POWER SUPPLY CHARACTERIST	rics		-			
Power Supply Range		Full	2	-	12	V
Positive Supply Current, I+	V+ = 3.6V, V- = 0V, V _{INH} , V _{ADD} = 0V or V+,	Full	-7	-	7	μΑ
Positive Supply Current, I-	Switch On or Off		-1	-	1	μA

Test Circuits and Waveforms



Logic input waveform is inverted for switches that have the opposite logic sense.

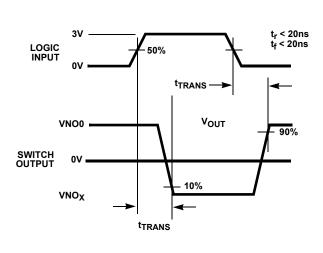
FIGURE 1A. ENABLE $t_{\mbox{ON}}/t_{\mbox{OFF}}$ MEASUREMENT POINTS



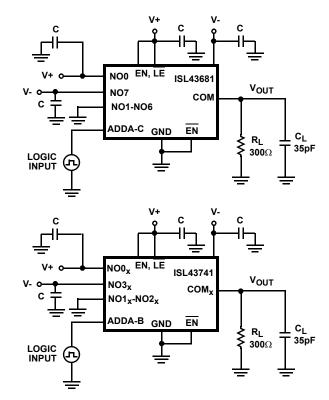
Repeat test for other switches. C_L includes fixture and stray capacitance.

$$V_{OUT} = V_{(NO \text{ or NC})} \frac{R_L}{R_L + R_{(ON)}}$$

FIGURE 1B. ENABLE $t_{\mbox{ON}}/t_{\mbox{OFF}}$ TEST CIRCUIT



Logic input waveform is inverted for switches that have the opposite logic sense.



Repeat test for other switches. C_L includes fixture and stray capacitance.

 $V_{OUT} = V_{(NO \text{ or NC})} \frac{R_L}{R_L + R_{(ON)}}$

FIGURE 1C. ADDRESS t_{TRANS} MEASUREMENT POINTS

FIGURE 1D. ADDRESS $t_{\mbox{\scriptsize TRANS}}$ TEST CIRCUIT

FIGURE 1. SWITCHING TIMES

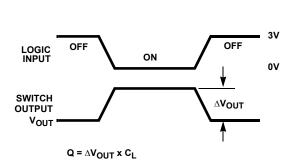
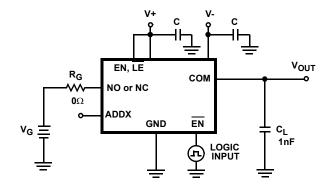


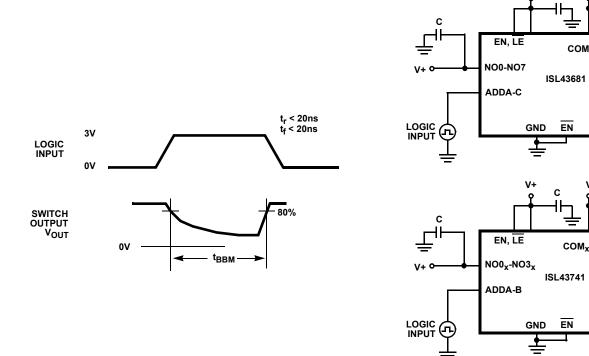
FIGURE 2A. Q MEASUREMENT POINTS



Repeat test for other switches.

FIGURE 2B. Q TEST CIRCUIT

FIGURE 2. CHARGE INJECTION



Repeat test for other switches. C_L includes fixture and stray capacitance.

FIGURE 3A. t_{BBM} MEASUREMENT POINTS

FIGURE 3B. $t_{\mbox{\footnotesize{BBM}}}$ TEST CIRCUIT

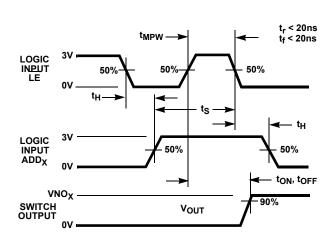
Vout

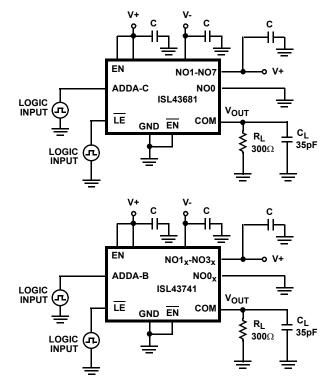
 v_{OUT}

35pF

35pF

FIGURE 3. BREAK-BEFORE-MAKE TIME





Logic input waveform is inverted for switches that have the opposite logic sense.

Repeat test for other switches. C_L includes fixture and stray capacitance.

 $V_{OUT} = V_{(NO \text{ or NC})} \frac{R_L}{R_L + R_{(ON)}}$

FIGURE 4A. LATCH t_S , t_H , t_{MPW} MEASUREMENT POINTS

FIGURE 4B. LATCH t_{S} , t_{H} , t_{MPW} TEST CIRCUIT

FIGURE 4. LATCH SETUP AND HOLD TIMES

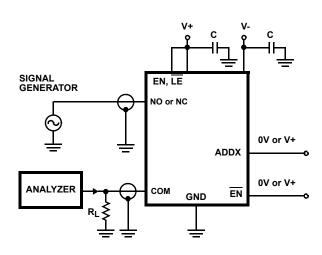


FIGURE 5. OFF ISOLATION TEST CIRCUIT

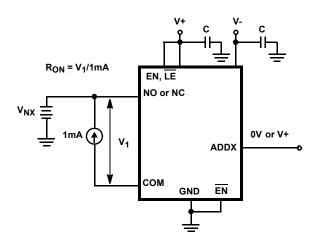


FIGURE 6. RON TEST CIRCUIT

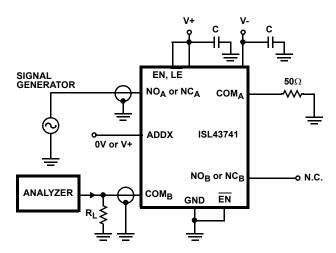


FIGURE 7. CROSSTALK TEST CIRCUIT

Detailed Description

The ISL43681 and ISL43741 multiplexers offer precise switching capability from a bipolar $\pm 2V$ to $\pm 6V$ or a single 2V to 12V supply with low on-resistance (39 Ω) and high speed operation (t_{ON} = 38ns, t_{OFF} = 19ns) with dual 5V supplies.

They have an inhibit and inhibit bar pin to simultaneously open all signal paths. They also have a latch bar pin to lock in the last switch address.

The devices are especially well suited for applications using ±5V supplies. With ±5V supplies the performance (R_{ON}, Leakage, Charge Injection, etc.) is best in class.

High frequency applications also benefit from the wide bandwidth, and the very high off isolation and crosstalk rejection.

Supply Sequencing And Overvoltage Protection

With any CMOS device, proper power supply sequencing is required to protect the device from excessive input currents which might permanently damage the IC. All I/O pins contain ESD protection diodes from the pin to V+ and to V- (see Figure 9). To prevent forward biasing these diodes, V+ and V- must be applied before any input signals, and input signal voltages must remain between V+ and V-. If these conditions cannot be guaranteed, then one of the following two protection methods should be employed.

Logic inputs can easily be protected by adding a $1k\Omega$ resistor in series with the input (see Figure 9). The resistor limits the input current below the threshold that produces permanent damage, and the sub-microamp input current produces an insignificant voltage drop during normal operation.

This method is not applicable for the signal path inputs. Adding a series resistor to the switch input defeats the purpose of using a low R_{ON} switch, so two small signal

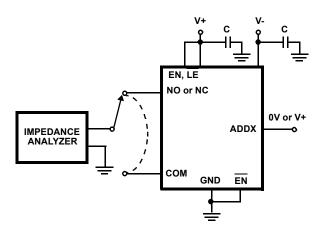


FIGURE 8. CAPACITANCE TEST CIRCUIT

diodes can be added in series with the supply pins to provide overvoltage protection for all pins (see Figure 9). These additional diodes limit the analog signal from 1V below V+ to 1V above V-. The low leakage current performance is unaffected by this approach, but the switch resistance may increase, especially at low supply voltages.

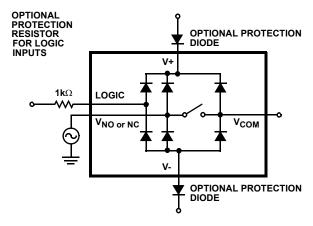


FIGURE 9. INPUT OVERVOLTAGE PROTECTION

Power-Supply Considerations

The ISL43681 and ISL43741 construction is typical of most CMOS analog switches, in that they have three supply pins: V+, V-, and GND. V+ and V- drive the internal CMOS switches and set their analog voltage limits, so there are no connections between the analog signal path and GND. Unlike switches with a 13V maximum supply voltage, the ISL43681 and ISL43741 15V maximum supply voltage provides plenty of room for the 10% tolerance of 12V supplies (±6V or 12V single supply), as well as room for overshoot and noise spikes.

This family of switches performs equally well when operated with bipolar or single voltage supplies. The minimum

recommended supply voltage is 2V or $\pm 2V$. It is important to note that the input signal range, switching times, and on-resistance degrade at lower supply voltages. Refer to the electrical specification tables and *Typical Performance* curves for details.

V+ and GND power the internal logic (thus setting the digital switching point) and level shifters. The level shifters convert the logic levels to switched V+ and V- signals to drive the analog switch gate terminals.

Logic-Level Thresholds

V+ and GND power the internal logic stages, so V- has no affect on logic thresholds. This switch family is TTL compatible (0.8V and 2.4V) over a V+ supply range of 2.7V to 10V. At 12V the V $_{\rm IH}$ level is about 3.3V. This is still below the CMOS guaranteed high output minimum level of 4V, but noise margin is reduced. For best results with a 12V supply, use a logic family that provides a V $_{\rm OH}$ greater than 4V.

The digital input stages draw supply current whenever the digital input voltage is not at one of the supply rails. Driving the digital input signals from GND to V+ with a fast transition time minimizes power dissipation.

High-Frequency Performance

In 50Ω systems, signal response is reasonably flat even past 100MHz (see Figures 18 and 19). Figures 18 and 19 also illustrates that the frequency response is very consistent over varying analog signal levels.

An OFF switch acts like a capacitor and passes higher frequencies with less attenuation, resulting in signal feed

through from a switch's input to its output. Off Isolation is the resistance to this feed through, while Crosstalk indicates the amount of feed through from one switch to another. Figure 20 details the high Off Isolation and Crosstalk rejection provided by this family. At 10MHz, Off Isolation is about 55dB in 50Ω systems, decreasing approximately 20dB per decade as frequency increases. Higher load impedances decrease Off Isolation and Crosstalk rejection due to the voltage divider action of the switch OFF impedance and the load impedance.

Leakage Considerations

Reverse ESD protection diodes are internally connected between each analog-signal pin and both V+ and V-. One of these diodes conducts if any analog signal exceeds V+ or V-.

Virtually all the analog leakage current comes from the ESD diodes to V+ or V-. Although the ESD diodes on a given signal pin are identical and therefore fairly well balanced, they are reverse biased differently. Each is biased by either V+ or V- and the analog signal. This means their leakages will vary as the signal varies. The difference in the two diode leakages to the V+ and V- pins constitutes the analog-signal-path leakage current. All analog leakage current flows between each pin and one of the supply terminals, not to the other switch terminal. This is why both sides of a given switch can show leakage currents of the same or opposite polarity. There is no connection between the analog signal paths and GND.

Typical Performance Curves TA = 25°C, Unless Otherwise Specified

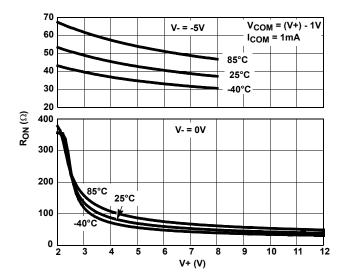


FIGURE 10. ON RESISTANCE vs SUPPLY VOLTAGE

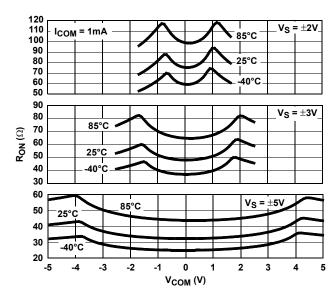


FIGURE 11. ON RESISTANCE vs SWITCH VOLTAGE

Typical Performance Curves T_A = 25°C, Unless Otherwise Specified (Continued)

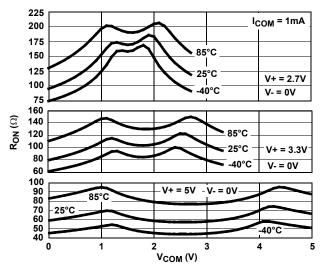


FIGURE 12. ON RESISTANCE vs SWITCH VOLTAGE

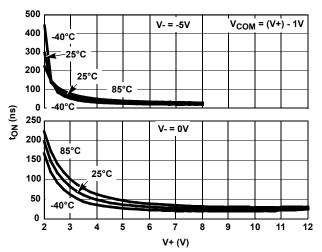


FIGURE 14. ENABLE TURN - ON TIME vs SUPPLY VOLTAGE

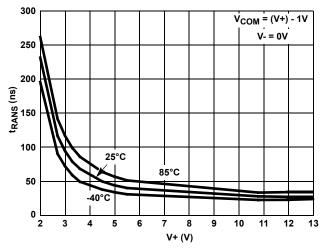


FIGURE 16. ADDRESS TRANS TIME vs SINGLE SUPPLY VOLTAGE

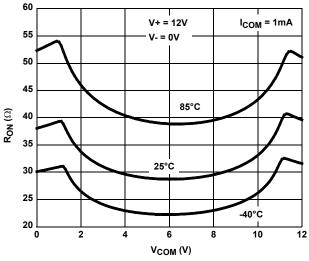


FIGURE 13. ON RESISTANCE vs SWITCH VOLTAGE

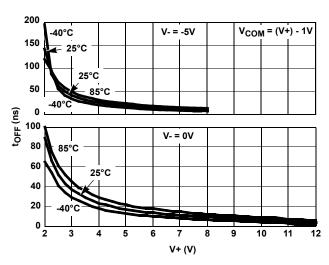


FIGURE 15. ENABLE TURN - OFF TIME vs SUPPLY VOLTAGE

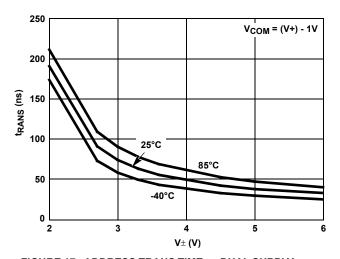


FIGURE 17. ADDRESS TRANS TIME vs DUAL SUPPLY VOLTAGE

Typical Performance Curves T_A = 25°C, Unless Otherwise Specified (Continued)

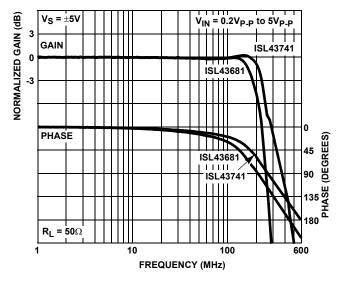


FIGURE 18. FREQUENCY RESPONSE

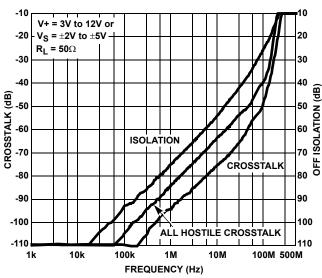


FIGURE 20. CROSSTALK AND OFF ISOLATION

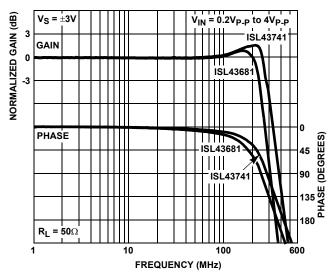


FIGURE 19. FREQUENCY RESPONSE

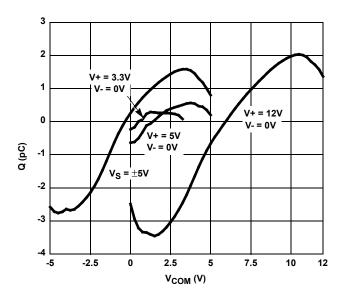


FIGURE 21. CHARGE INJECTION vs SWITCH VOLTAGE

Die Characteristics

SUBSTRATE POTENTIAL (POWERED UP):

V-

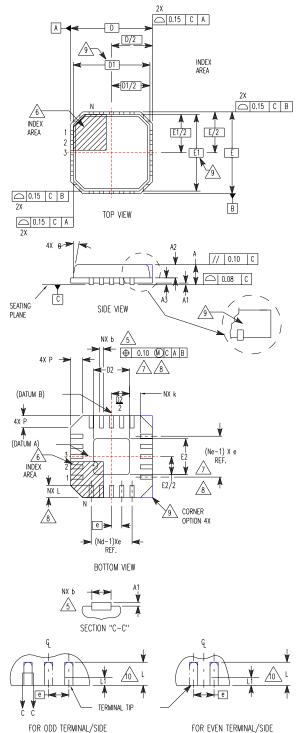
TRANSISTOR COUNT:

ISL43681: 193 ISL43741: 193

PROCESS:

Si Gate CMOS

Quad Flat No-Lead Plastic Package (QFN) Micro Lead Frame Plastic Package (MLFP)



L20.4x4
20 LEAD QUAD FLAT NO-LEAD PLASTIC PACKAGE
(COMPLIANT TO JEDEC MO-220VGGD-1 ISSUE I)

SYMBOL	MIN	NOMINAL	MAX	NOTES	
Α	0.80	0.90	1.00	-	
A1	-	0.02	0.05	-	
A2	-	0.65 1.		9	
A3		0.20 REF		9	
b	0.18	0.25	0.30	5, 8	
D		4.00 BSC		-	
D1		3.75 BSC		9	
D2	1.95	2.10	2.25	7, 8	
E		4.00 BSC			
E1		3.75 BSC	9		
E2	1.95	2.10	2.25	7, 8	
е		0.50 BSC	-		
k	0.20	-	-	-	
L	0.35	0.60	0.75	8	
N		20		2	
Nd	5			3	
Ne	5			3	
Р	-	-	0.60	9	
θ	-	-	12	9	

Rev. 2 11/04

NOTES:

- 1. Dimensioning and tolerancing conform to ASME Y14.5-1994.
- 2. N is the number of terminals.
- 3. Nd and Ne refer to the number of terminals on each D and E.
- 4. All dimensions are in millimeters. Angles are in degrees.
- 5. Dimension b applies to the metallized terminal and is measured between 0.15mm and 0.30mm from the terminal tip.
- The configuration of the pin #1 identifier is optional, but must be located within the zone indicated. The pin #1 identifier may be either a mold or mark feature.
- 7. Dimensions D2 and E2 are for the exposed pads which provide improved electrical and thermal performance.
- 8. Nominal dimensions are provided to assist with PCB Land Pattern Design efforts, see Intersil Technical Brief TB389.
- 9. Features and dimensions A2, A3, D1, E1, P & θ are present when Anvil singulation method is used and not present for saw singulation.

All Intersil U.S. products are manufactured, assembled and tested utilizing ISO9001 quality systems. Intersil Corporation's quality certifications can be viewed at www.intersil.com/design/quality

Intersil products are sold by description only. Intersil Corporation reserves the right to make changes in circuit design, software and/or specifications at any time without notice. Accordingly, the reader is cautioned to verify that data sheets are current before placing orders. Information furnished by Intersil is believed to be accurate and reliable. However, no responsibility is assumed by Intersil or its subsidiaries for its use; nor for any infringements of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of Intersil or its subsidiaries.

For information regarding Intersil Corporation and its products, see www.intersil.com